NOTES:

1. SUBSTRATE MATERIAL: FUSED SILICA

2. COATING (APPLY ACROSS CLEAR APERTURE)

S1: Ultrafast Laser R(AVG) >99% @ 760 - 840nm

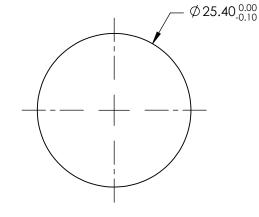
GDD SPECIFICATION: 0 ±30fs² @ 740-860nm

DAMAGE THRESHOLD: 1000-on-1: >0.25 J/cm2, 100 fs, 100 Hz, @ 800 nm

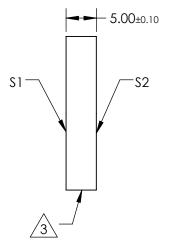
S2: NONE

3. FINE GROUND SURFACE

4. RoHS COMPLIANT



FOR INFORMATION ONLY: DO NOT MANUFACTURE PARTS TO THIS DRAWING



SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

REV. A	S1	\$2				Edmund Optics [®]	
SHAPE	PLANO	PLANO					
CLEAR APERTURE	Ø20.32	N/A			TITLE	760 - 840nm, 25.4mm Dia. x 5.00mm Thickness, Ultrafast Laser Line Mirror	
SURFACE QUALITY	20-10	COMMERCIAL POLISH					
SURFACE FLATNESS	λ/8	N/A	1				
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO		IEET OF 1